

TEST REPORT

Reference No...... : WTX20X06036502W
FCC ID..... : 2AC67-X100
Applicant : Xiamen VBeT Electronics Co., Ltd.
Address : N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese
Scholars, PRC
Product Name : VT Series Headsets
Test Model..... : X100 DUO
Standards : FCC PART15 SUBPART B
Date of Receipt sample : Jun.12, 2020
Date of Test..... : Jun.12, 2020 to Jun.18, 2020
Date of Issue : Jun.18, 2020
Test Result..... : **Pass**

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

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Report version

Version No.	Date of issue	Description
Rev.00	Jun.18, 2020	Original
/	/	/

1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

Client Information

Applicant: Xiamen VBeT Electronics Co., Ltd.
 Address of applicant: N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC

Manufacturer: Xiamen VBeT Electronics Co., Ltd.
 Address of manufacturer: N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC

General Description of EUT	
Product Name:	VT Series Headsets
Trade Name:	VT
Model No.:	X100 DUO
Adding Model(s):	X100, VT1000, VT1200, VT2000, VT3000, VT5000,
	VT5009, VT6000, VT6200, VT6300, VT6909, VT6907,
	VT1500, VT7000
Software Version:	1.0
Hardware Version:	1.0
<p><i>Note: The test data is gathered from a production sample, provided by the manufacturer. The appearance of others models listed in the report is different from main-test model X100 DUO, but the circuit and the electronic construction do not change, declared by the manufacturer.</i></p>	

Technical Characteristics of EUT	
Rated Voltage:	DC 5V
Rated Current:	/
Rated Power:	/
Power Adapter Model:	/
Highest Internal Frequency:	Below 108MHz
Classification of ITE:	Class B

1.2 Test Standards

The tests were performed according to following standards:

FCC Rules Part 15 Subpart B: Unintentional Radiators.

ANSI C63.4-2014: American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2014, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

1.4 Test Facility

Address of the test laboratory

Laboratory: Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. The Designation Number is CN5010, and Test Firm Registration Number is 125990.

Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission. The test modes were adapted according to the operation manual for use, more detailed description as follows:

Test Mode List:

Test Mode	Description	Remark	Power Supply Mode
TM1	Normal Working	Connect to PC	DC5V from PC

EUT Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
USB Cable	1.3	Unshielded	Without Ferrite

Auxiliary Equipment List and Details

Description	Manufacturer	Model	Serial Number
Notebook	Lenovo	E445	EB12648265

Special Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
/	/	/	/

1.6 Measurement Uncertainty

Measurement uncertainty		
Parameter	Conditions	Uncertainty
Conducted Emissions	Conducted	9-150kHz ± 3.74 dB
		0.15-30MHz ± 3.34 dB
Radiated Emissions	Radiated	30-200MHz ± 4.52 dB
		0.2-1GHz ± 5.56 dB
		1-6GHz ± 3.84 dB
		6-18GHz ± 3.92 dB

1.7 Test Equipment List and Details

Description	Manufacturer	Model	Serial No.	Cal Date	Due Date
Spectrum Analyzer	Agilent	E4407B	MY41440400	2020-04-28	2021-04-27
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2020-04-28	2021-04-27
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2020-04-28	2021-04-27
Amplifier	Agilent	8447F	3113A06717	2020-04-28	2021-04-27
Amplifier	C&D	PAP-1G18	2002	2020-04-28	2021-04-27
Broadband Antenna	Schwarz beck	VULB9163	9163-333	2019-05-05	2021-05-04
Horn Antenna	ETS	3117	00086197	2019-05-05	2021-05-04
Loop Antenna	Schwarz beck	FMZB 1516	9773	2019-05-05	2021-05-04
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2020-04-28	2021-04-27
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2020-04-28	2021-04-27
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2020-04-28	2021-04-27

Software List			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission)*	Farad	EZ-EMC	RA-03A1

*Remark: indicates software version used in the compliance certification testing

2. SUMMARY OF TEST RESULTS

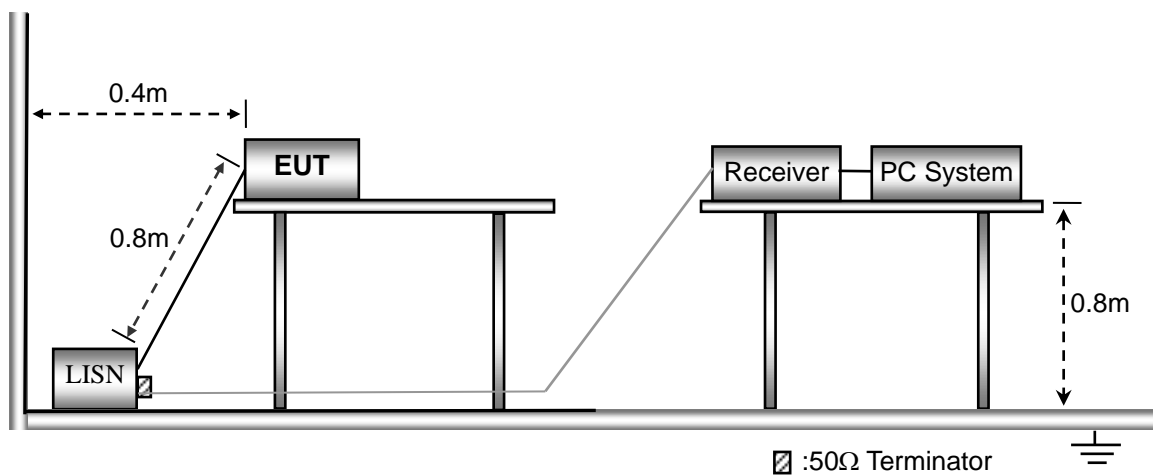
Description of Test	Result
§15.107(a) Conducted Emission	Compliant
§15.109(a) Radiated Emission	Compliant

3. Conducted Emissions

3.1 Test Procedure

Test is conducting under the description of ANSI C63.4-2014, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

3.2 Basic Test Setup Block Diagram



3.3 Environmental Conditions

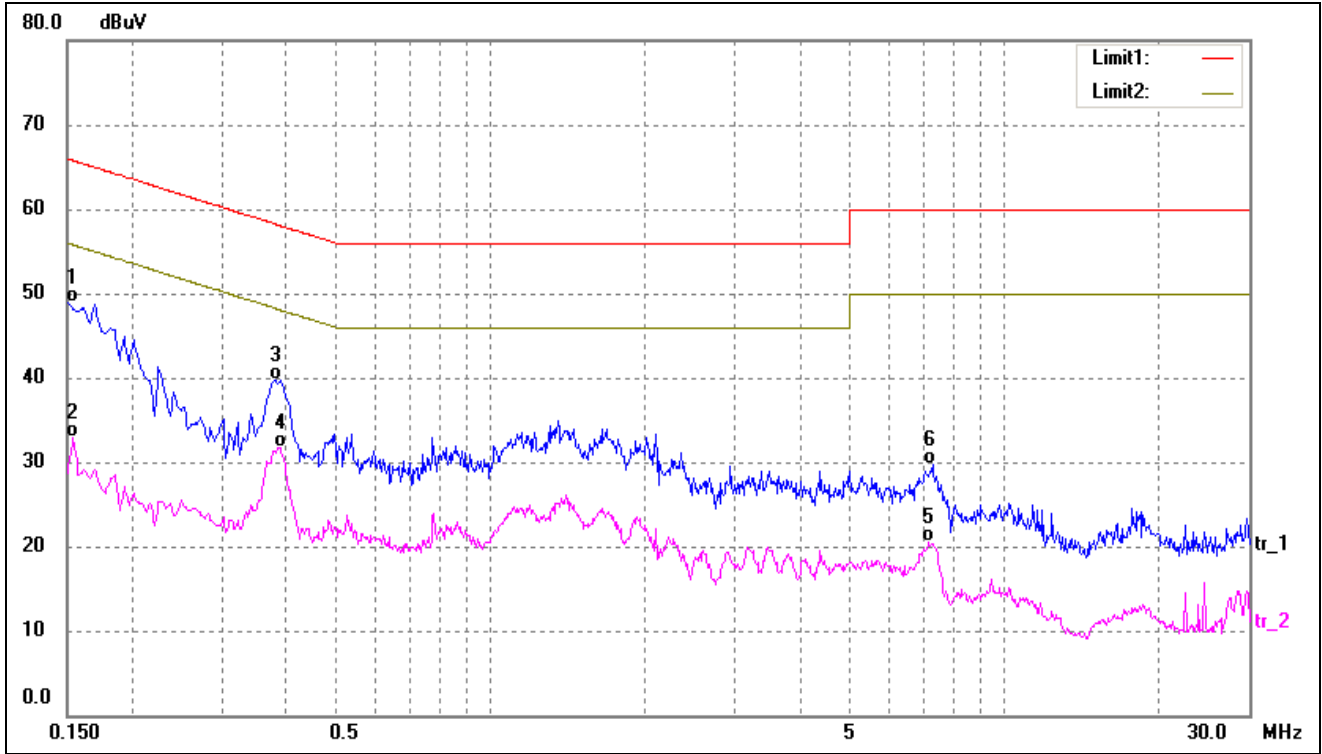
Temperature:	26 °C
Relative Humidity:	60%
ATM Pressure:	1011 mbar

3.4 Summary of Test Results

Look at the graphs and data below:

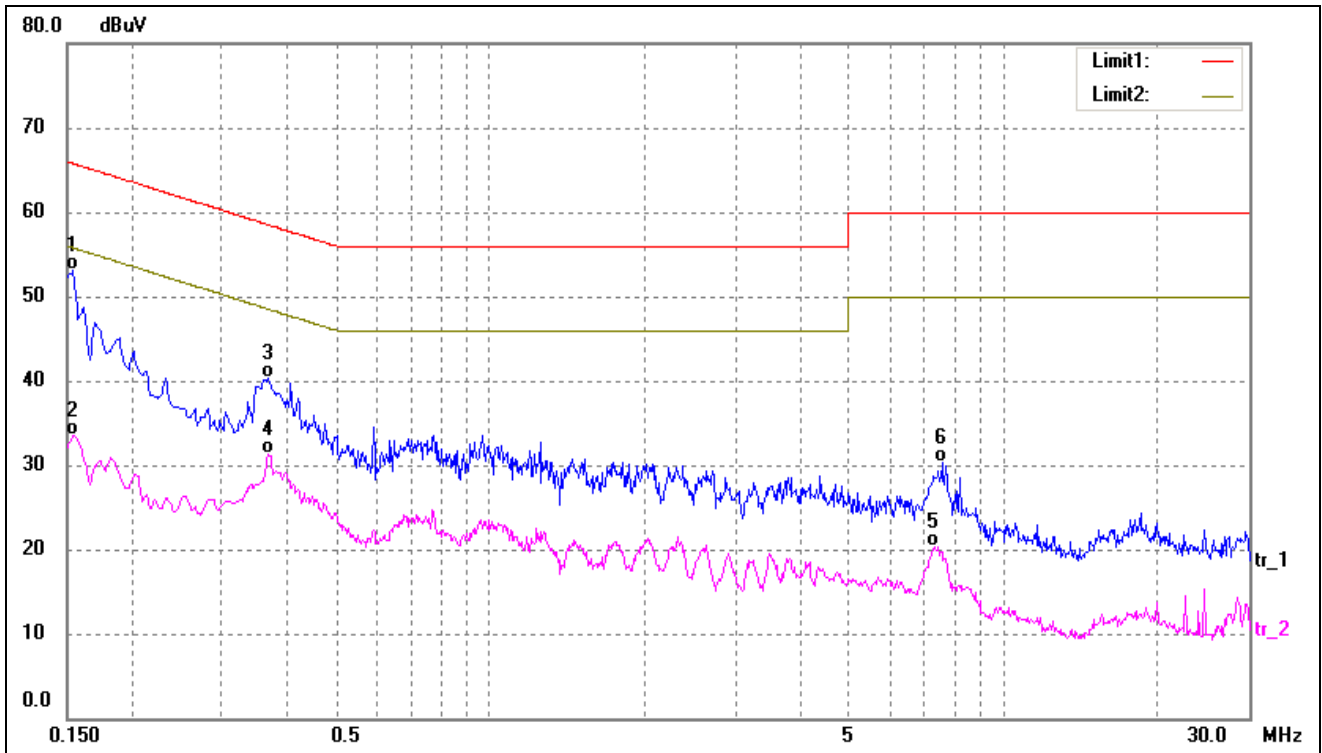
3.5 Conducted Emissions Test Data

Test mode:	TM1	Polarity:	Line
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No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1500	39.05	9.95	49.00	65.99	-16.99	QP
2	0.1539	22.90	9.95	32.85	55.78	-22.93	AVG
3	0.3820	29.68	10.02	39.70	58.23	-18.53	QP
4*	0.3899	21.62	10.01	31.63	48.06	-16.43	AVG
5	7.1580	9.89	10.52	20.41	50.00	-29.59	AVG
6	7.2660	19.12	10.52	29.64	60.00	-30.36	QP

Test mode:	TM1	Polarity:	Neutral
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No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1*	0.1539	43.17	9.95	53.12	65.78	-12.66	QP
2	0.1539	23.59	9.95	33.54	55.78	-22.24	AVG
3	0.3700	30.25	10.02	40.27	58.50	-18.23	QP
4	0.3700	21.22	10.02	31.24	48.50	-17.26	AVG
5	7.3300	9.75	10.53	20.28	50.00	-29.72	AVG
6	7.5700	19.77	10.52	30.29	60.00	-29.71	QP

4. RADIATED EMISSION

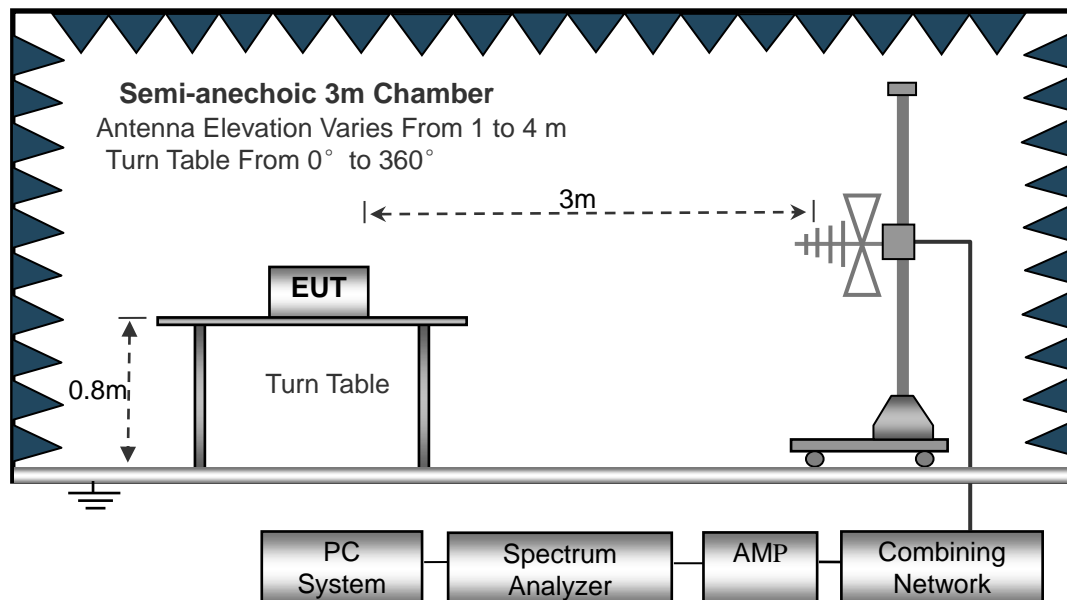
4.1 Test Procedure

The setup of EUT is according with per ANSI C63.4-2014 measurement procedure. The specification used was with the FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

4.2 Block Diagram of Test Setup



4.3 Test Receiver Setup

Frequency :9kHz-30MHz

RBW=10KHz,

VBW =30KHz

Sweep time= Auto

Trace = max hold

Detector function = peak

Frequency :30MHz-1GHz

RBW=120KHz,

VBW=300KHz

Sweep time= Auto

Trace = max hold

Detector function = peak, QP

Frequency :Above 1GHz

RBW=1MHz,

VBW=3MHz(Peak), 10Hz(AV)

Sweep time= Auto

Trace = max hold

Detector function = peak, AV

4.4 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\begin{aligned} \text{Corr. Ampl.} &= \text{Indicated Reading} + \text{Correct} \\ \text{Correct} &= \text{Ant.Factor} + \text{Cable Loss} - \text{Ampl.Gain} \end{aligned}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -6dB μ V means the emission is 6dB μ V below the maximum limit for a Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{FCC Part 15.109(a) Limit}$$

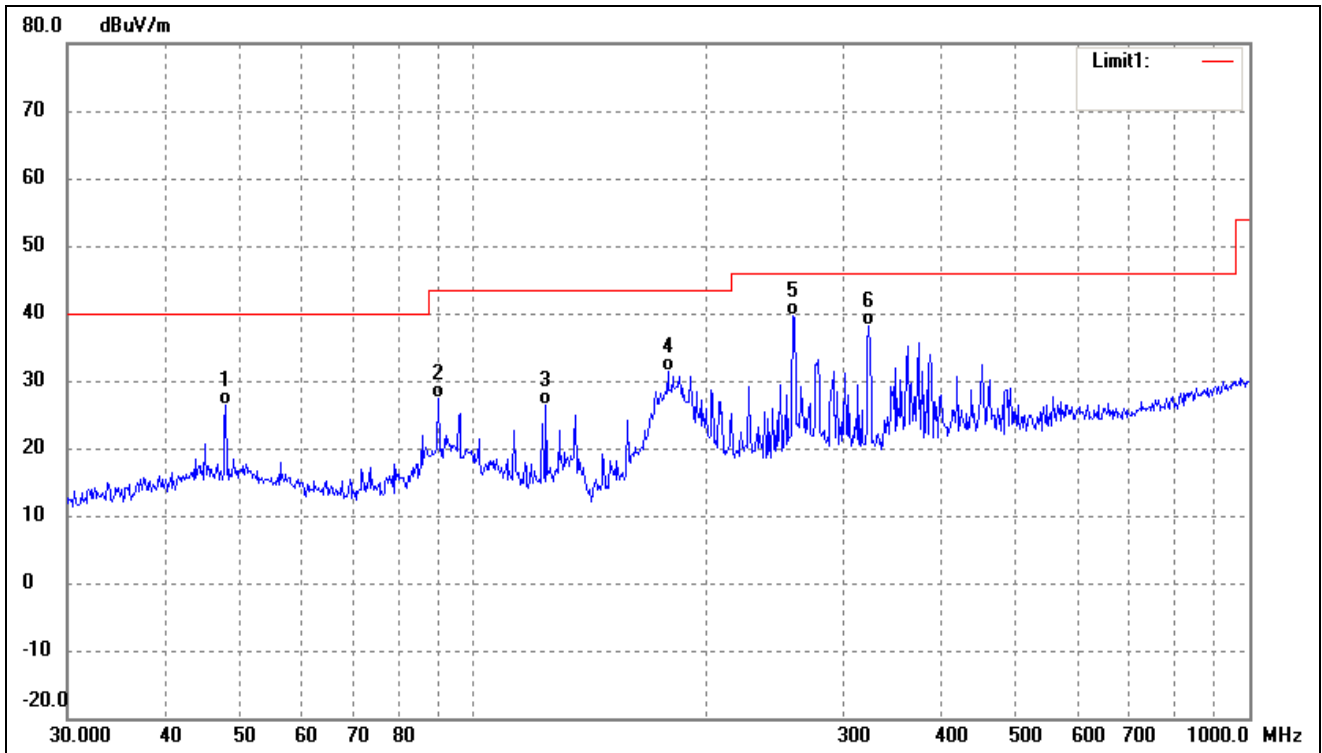
4.5 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	55 %
ATM Pressure:	1011 mbar

4.6 Summary of Test Results

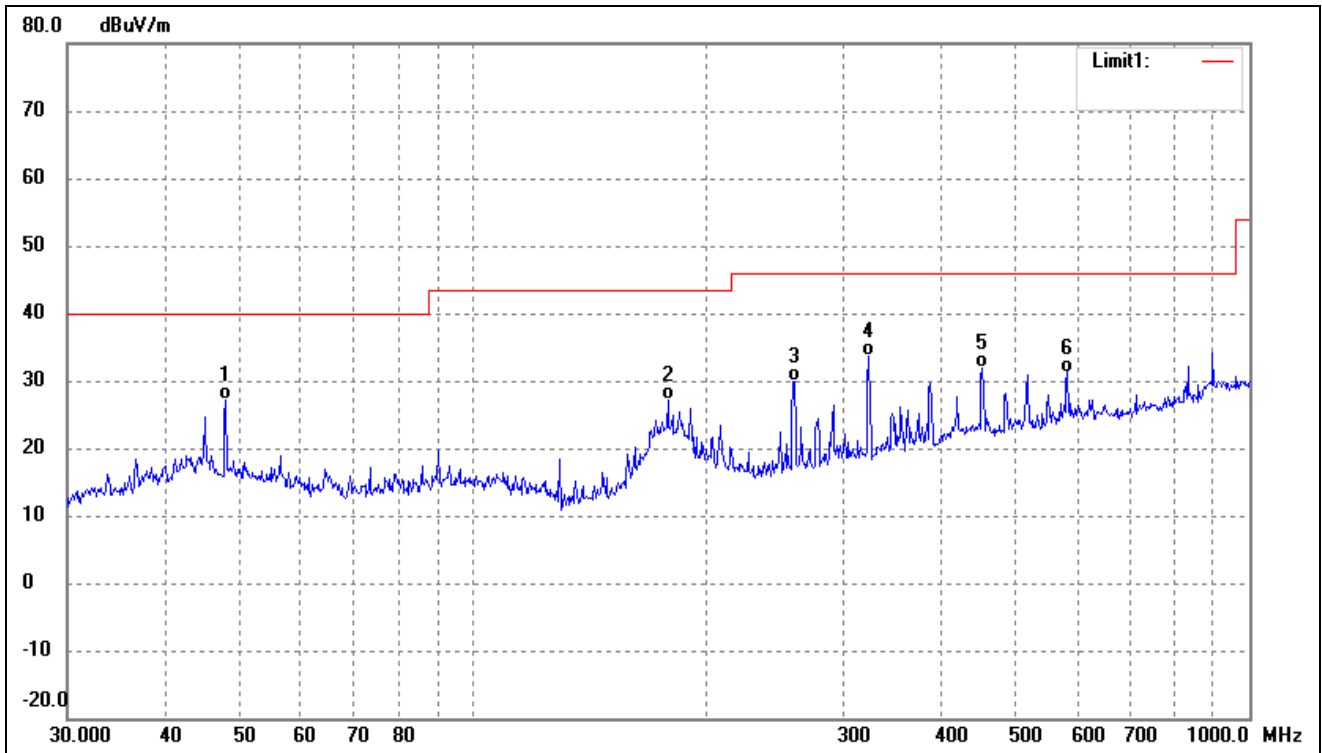
Look at the graphs and data below:

Test mode:	TM1	Polarity:	Horizontal
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No.	Frequency (MHz)	Reading (dBuV/m)	Correct (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	47.9940	36.63	-10.34	26.29	40.00	-13.71	-	-	QP
2	90.2205	41.92	-14.50	27.42	43.50	-16.08	-	-	QP
3	124.1330	40.79	-14.31	26.48	43.50	-17.02	-	-	QP
4	178.1327	44.74	-13.39	31.35	43.50	-12.15	-	-	QP
5	258.3264	48.66	-9.10	39.56	46.00	-6.44	-	-	QP
6	323.3204	45.58	-7.39	38.19	46.00	-7.81	-	-	QP

Test mode:	TM1	Polarity:	Vertical
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No.	Frequency (MHz)	Reading (dBuV/m)	Correct (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	47.9940	37.50	-10.34	27.16	40.00	-12.84	-	-	QP
2	178.1327	40.47	-13.39	27.08	43.50	-16.42	-	-	QP
3	259.2338	38.86	-9.08	29.78	46.00	-16.22	-	-	QP
4	323.3204	41.10	-7.39	33.71	46.00	-12.29	-	-	QP
5	452.7197	36.46	-4.66	31.80	46.00	-14.20	-	-	QP
6	582.7425	33.71	-2.46	31.25	46.00	-14.75	-	-	QP

Remark: '-' Means the test Degree and Height are not recorded by the test software and only show the worst case in the test report.